

**OSCILLATION-BASED TEST IN MIXED-SIGNAL  
CIRCUITS: 36 (FRONTIERS IN ELECTRONIC  
TESTING)**

Gregory Geren

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## Oscillation-Based Test in Mixed-Signal Circuits

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Testing mixed-signal cores: a practical oscillation-based test in an analog of oscillation-based-test output signals for switched-capacitor circuits Microelectronics Journal 36 (12), , Frontiers in Electronic Testing). Springer.

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Hence, each pyramidal neuron receives input from 9 out of background sources. The Transfer Function of quadrature oscillator is given by 1. A neural-network-based fault diagnosis method has been developed in Reference 52 using a wavelet transform as a preprocessor to reduce the number of input features to the neural network.

In this section we introduce the BrainScaleS neuromorphic wafer-scale hardware. The key aspect of the model is its modularity, which manifests itself on two levels. Synapse drivers can be connected in a chain, forwarding their input to their top or bottom neighbours, thereby allowing to increase the number of synapse rows fed by the same routing bus.

When compensated via the inclusion of multiple background sources, then even finite population sizes coupled with random elimination of synapses lead to locally inhomogeneous synapse loss and further increase the variability of neuronal activity. The small remaining deviations from the default model can be attributed to the inhomogeneity of the synapse loss and the fixed delays on the wafer.